

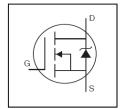
# **AUTOMOTIVE GRADE**



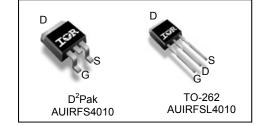
HEXFET® Power MOSFET

### **Features**

- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Timax
- Lead-Free, RoHS Compliant
- Automotive Qualified \*



V <sub>DSS</sub>	100V
R <sub>DS(on)</sub> typ.	3.9mΩ
max.	4.7mΩ
I <sub>D</sub>	180A



G	D	S
Gate	Drain	Source

# Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications

Base part number	Dookogo Typo	Standard Pack		Orderable Port Number
Base part number	Package Type	Form	Quantity	Orderable Part Number
AUIRFSL4010	TO-262	Tube	50	AUIRFSL4010
AUIRFS4010	D²-Pak	Tube	50	AUIRFS4010
AUIRF54010	D-Pak	Tape and Reel Left	800	AUIRFS4010TRL

### **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	180	
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	127	Α
I <sub>DM</sub>	Pulsed Drain Current ①	720	
$P_D @ T_C = 25^{\circ}C$	Maximum Power Dissipation	375	W
	Linear Derating Factor	2.5	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 20	V
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) ②	318	mJ
I <sub>AR</sub>	Avalanche Current ①	See Fig. 14, 15, 22a, 22b	Α
E <sub>AR</sub>	Repetitive Avalanche Energy ①		mJ
dv/dt	Peak Diode Recovery ③	31	V/ns
$T_J$	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

## **Thermal Resistance**

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-Case ® ®		0.40	°C/W
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount), D² Pak ∅		40	C/VV

HEXFET® is a registered trademark of Infineon.

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<sup>\*</sup>Qualification standards can be found at www.infineon.com



# Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	100			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.10		V/°C	Reference to 25°C, I <sub>D</sub> = 5mA ①
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		3.9	4.7	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 106A ④
$V_{GS(th)}$	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
gfs	Forward Trans conductance	189			S	$V_{DS} = 25V, I_{D} = 106A$
$R_G$	Internal Gate Resistance		2.0		Ω	
	Drain to Course Leakens Current			20		V <sub>DS</sub> = 100V, V <sub>GS</sub> = 0V
I <sub>DSS</sub>	Drain-to-Source Leakage Current			250	μA	$V_{DS} = 100V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	- A	V <sub>GS</sub> = 20V
	Gate-to-Source Reverse Leakage			-100	nA	V <sub>GS</sub> = -20V

# Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

$Q_g$	Total Gate Charge	 143	215		I <sub>D</sub> = 106A
$Q_{gs}$	Gate-to-Source Charge	 38			$V_{DS} = 50V$
$Q_{gd}$	Gate-to-Drain Charge	 50		nC	V <sub>GS</sub> = 10V4
Q <sub>sync</sub>	Total Gate Charge Sync. (Q <sub>g</sub> - Q <sub>gd</sub> )	 93			
$t_{d(on)}$	Turn-On Delay Time	 21			$V_{DD} = 65V$
t <sub>r</sub>	Rise Time	 86		nc	$I_{D} = 106A$
$t_{d(off)}$	Turn-Off Delay Time	 100		ns	$R_G = 2.7\Omega$
t <sub>f</sub>	Fall Time	 77			V <sub>GS</sub> = 10V4
C <sub>iss</sub>	Input Capacitance	 9575			$V_{GS} = 0V$
C <sub>oss</sub>	Output Capacitance	 660			V <sub>DS</sub> = 50V
C <sub>rss</sub>	Reverse Transfer Capacitance	 270		рF	f = 1.0MHz, See Fig. 5
Coss eff.(ER)	Effective Output Capacitance (Energy Related)	 757			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 80V $
Coss eff.(TR)	Effective Output Capacitance (Time Related)	 1112			$V_{GS}$ = 0V, $V_{DS}$ = 0V to 80V $\odot$

## **Diode Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions	
I <sub>S</sub>	Continuous Source Current (Body Diode)			180		MOSFET symbol showing the	
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ①			720		integral reverse p-n junction diode.	
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 106A, V_{GS} = 0V $ ④	
t <sub>rr</sub>	Reverse Recovery Time		72 81		ns	$T_J = 25^{\circ}C$ $V_{DD} = 85V$ $T_J = 125^{\circ}C$ $I_F = 106A$ ,	
Q <sub>rr</sub>	Reverse Recovery Charge		210 268		nC	$T_{J} = 25^{\circ}C$ di/dt = 100A/ $\mu$ s $\oplus$	
I <sub>RRM</sub>	Reverse Recovery Current		5.3		Α	T <sub>J</sub> = 25°C	
t <sub>on</sub>	Forward Turn-On Time	Intrinsic	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> +L <sub>D</sub> )				

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by  $T_{Jmax}$ , starting  $T_J = 25$ °C, L = 0.057mH,  $R_G = 25\Omega$ ,  $I_{AS} = 106$ A,  $V_{GS} = 10$ V. Part not recommended for use above this value.
- $\exists \quad I_{SD} \leq 106A, \ di/dt \leq 1319A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175^{\circ}C.$
- 4 Pulse width  $\leq 400 \mu s$ ; duty cycle  $\leq 2\%$ .
- $^{\circ}$  C<sub>oss</sub> eff. (TR) is a fixed capacitance that gives the same charging time as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>.  $^{\circ}$  C<sub>oss</sub> eff. (ER) is a fixed capacitance that gives the same energy as C<sub>oss</sub> while V<sub>DS</sub> is rising from 0 to 80% V<sub>DSS</sub>.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994
- ®  $R_\theta$  is measured at  $T_J$  approximately 90°C.

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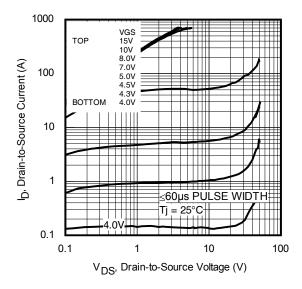


Fig. 1 Typical Output Characteristics

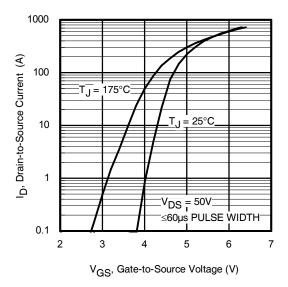


Fig. 3 Typical Transfer Characteristics

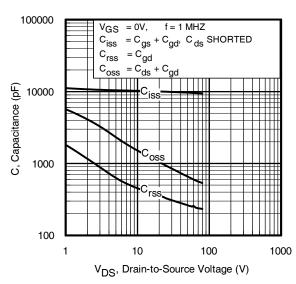


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

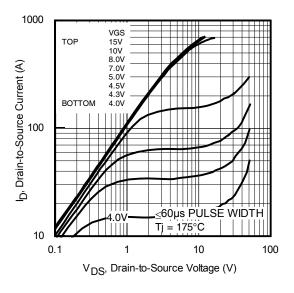


Fig. 2 Typical Output Characteristics

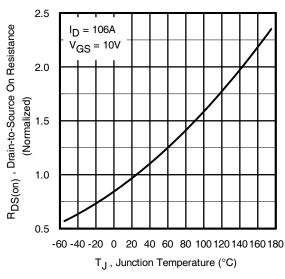


Fig. 4 Normalized On-Resistance vs. Temperature

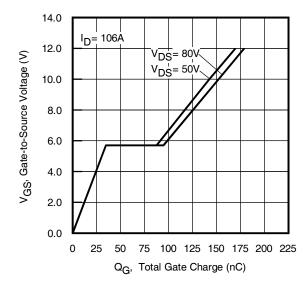


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

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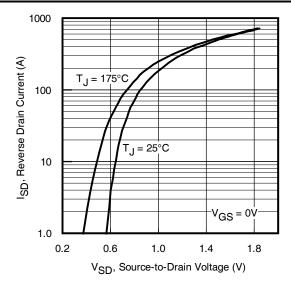


Fig. 7 Typical Source-to-Drain Diode Forward Voltage 200 180 160 140 Drain Current (A) 120 100 80 ک 60 40 20 0 25 50 75 100 125 150 175  $T_C$  , Case Temperature (°C)

Fg 9. Maximum Drain Current vs. Case Temperature

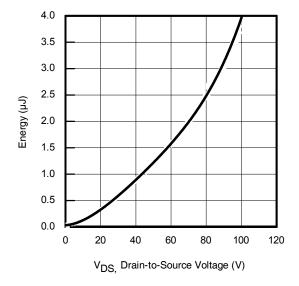


Fig 11. Typical Coss Stored Energy

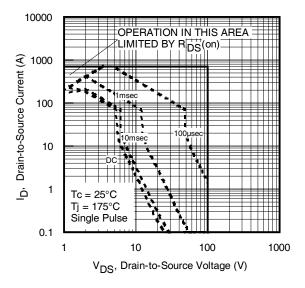


Fig 8. Maximum Safe Operating Area

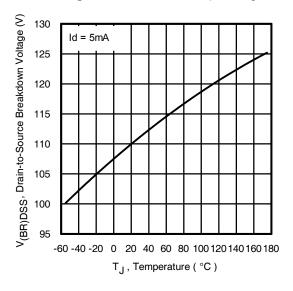


Fig 10. Drain-to-Source Breakdown Voltage

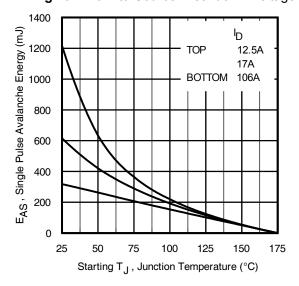


Fig 12. Maximum Avalanche Energy vs. Drain Current



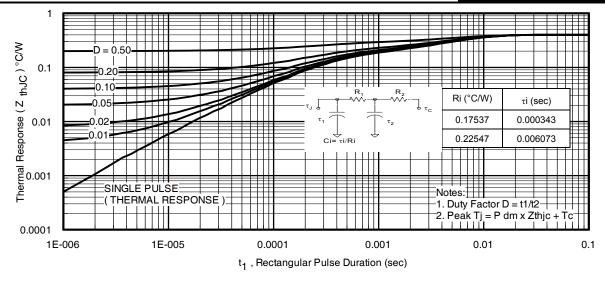


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

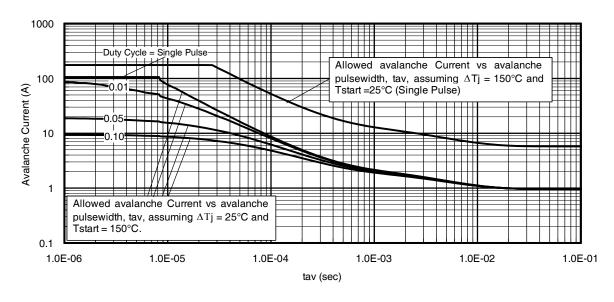


Fig 14. Avalanche Current vs. Pulse width

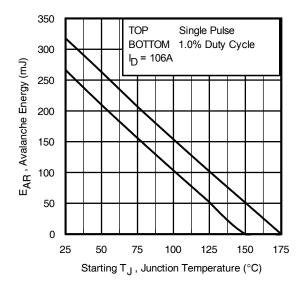


Fig 15. Maximum Avalanche Energy vs. Temperature

# Notes on Repetitive Avalanche Curves , Figures 14, 15: (For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption:
   Purely a thermal phenomenon and failure occurs at a temperature far in excess of Tjmax. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as T<sub>jmax</sub> is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 18a, 18b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- ΔT = Allowable rise in junction temperature, not to exceed T<sub>jmax</sub> (assumed as 25°C in Figure 13, 14).

tav = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \Delta T / \; Z_{thJC} \\ I_{av} &= 2\Delta T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$

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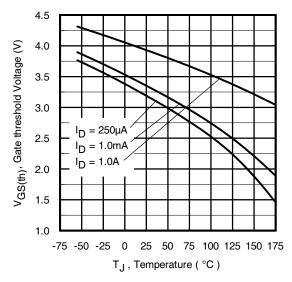


Fig 16. Threshold Voltage vs. Temperature

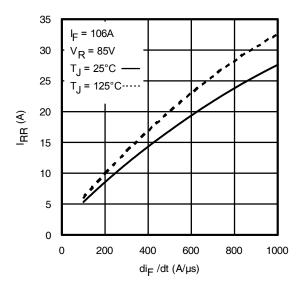


Fig. 18 - Typical Recovery Current vs. dif/dt

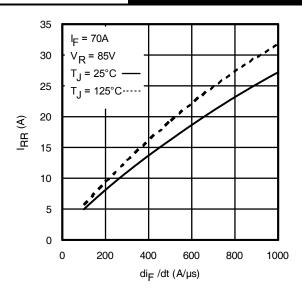


Fig. 17 - Typical Recovery Current vs. dif/dt

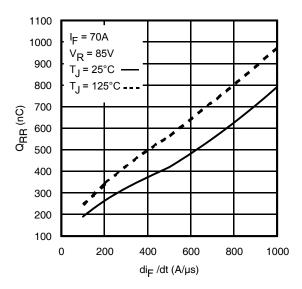


Fig. 19 - Typical Stored Charge vs. dif/dt

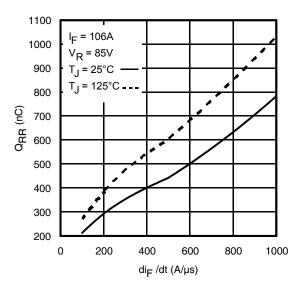


Fig. 20 - Typical Stored Charge vs. dif/dt

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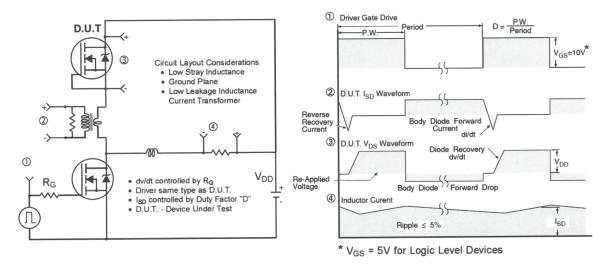


Fig 21. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

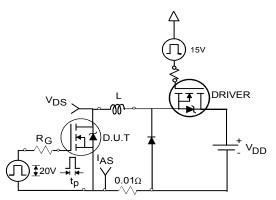


Fig 22a. Unclamped Inductive Test Circuit

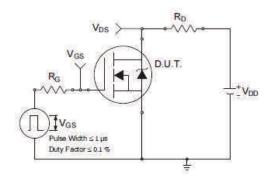


Fig 23a. Switching Time Test Circuit

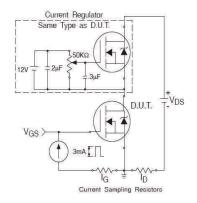


Fig 24a. Gate Charge Test Circuit

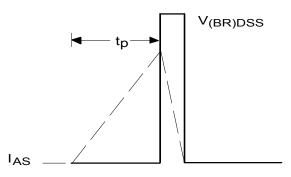


Fig 22b. Unclamped Inductive Waveforms

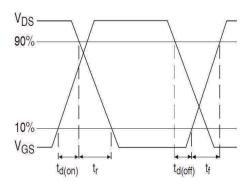


Fig 23b. Switching Time Waveforms

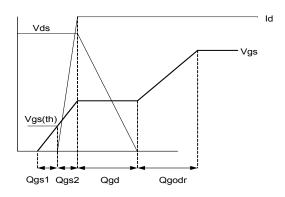
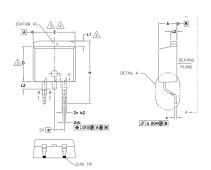
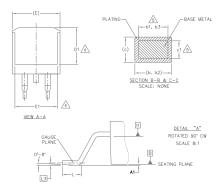


Fig 24b. Gate Charge Waveform



# D<sup>2</sup>Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))





MA	TF	Ç.	

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

5. DIMENSION 61, 63 AND c1 APPLY TO BASE METAL ONLY.

- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

S			N		
M B	MILLIMETERS INCHES			O T E S	
O L	MIN.	MAX.	MIN.	MAX.	E S
А	4.06	4.83	.160	.190	
A1	0.00	0.254	.000	.010	
Ь	0.51	0.99	.020	.039	
ь1	0.51	0.89	.020	.035	5
b2	1.14	1.78	.045	.070	
ь3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
с1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	_	.270	_	4
E	9.65	10.67	.380	.420	3,4
E1	6.22	_	.245	_	4
е	2.54	BSC	.100 BSC		
Н	14.61	15.88	.575	.625	
L	1.78	2.79	.070	.110	
L1	_	1.68	_	.066	4
L2	_	1.78	_	.070	
L3	0.25	BSC	.010	BSC	

### LEAD ASSIGNMENTS

### DIODES

1.— ANODE (TWO DIE) / OPEN (ONE DIE) 2, 4.— CATHODE 3.— ANODE

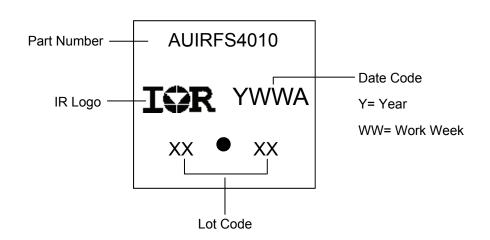
### HEXFET

IGBTs, CoPACK

# 1.- GATE 2, 4.- DRAIN 3.- SOURCE

1.- GATE 2, 4.- COLLECTOR 3.- EMITTER

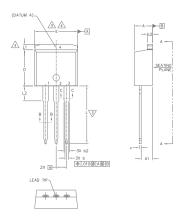
# D<sup>2</sup>Pak (TO-263AB) Part Marking Information

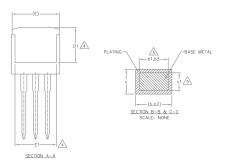


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# TO-262 Package Outline (Dimensions are shown in millimeters (inches)





- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

3. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.

- 6. CONTROLLING DIMENSION: INCH.
- 7.- OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(mox.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

### LEAD ASSIGNMENTS

### IGBTs, CoPACK

1.- GATE
2.- COLLECTOR
3.- EMITTER
4.- COLLECTOR

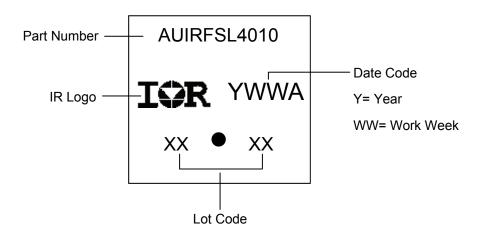
HEXFET DIODES

1.- ANODE (TWO DIE) / OPEN (ONE DIE) 2, 4.- CATHODE 3.- ANODE

J. –	SOURC
4	DRAIN

S Y M		N				
B	MILLIM	ETERS	INC	INCHES		
L	MIN.	MAX.	MIN.	MAX.	N O T E S	
А	4.06	4.83	.160	.190		
A1	2.03	3.02	.080	.119		
b	0.51	0.99	.020	.039		
b1	0.51	0.89	.020	.035	5	
b2	1.14	1.78	.045	.070		
ь3	1.14	1.73	.045	.068	5	
С	0.38	0.74	.015	.029		
c1	0.38	0.58	.015	.023	5	
c2	1.14	1.65	.045	.065		
D	8.38	9.65	.330	.380	3	
D1	6.86	_	.270	_	4	
E	9.65	10.67	.380	.420	3,4	
E1	6.22	_	.245		4	
е	2.54	BSC	.100	BSC		
L	13.46	14.10	.530	.555		
L1	_	1.65	_	.065	4	
L2	3.56	3.71	.140	.146		

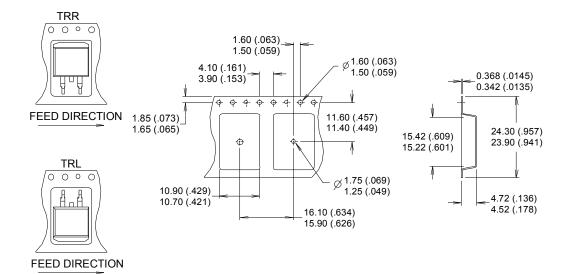
## **TO-262 Part Marking Information**

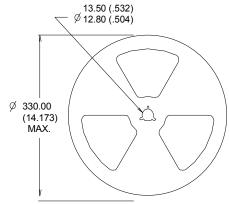


2017-08-23



# D<sup>2</sup>Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))

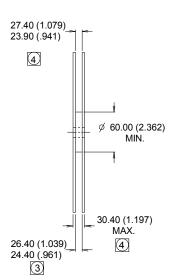






NOTES:

- 1. COMFORMS TO EIA-418.
- 2. CONTROLLING DIMENSION: MILLIMETER.
- 3 DIMENSION MEASURED @ HUB.
- INCLUDES FLANGE DISTORTION @ OUTER EDGE.



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### **Qualification Information**

		Automotive (per AEC-Q101)		
		Comments: This part number(s) passed Automotive qualification. Infineon's		
		Industrial and Consumer qualification level is granted by extension of the higher		
		Automotive level.		
Moisture Sensitivity Level		D <sup>2</sup> -Pak	MSL1	
		TO-262		
ESD	Machine Model		Class M4 (+/- 800V) <sup>†</sup>	
		AEC-Q101-002		
	Human Body Model	Class H3A (+/- 6000V) <sup>†</sup>		
		AEC-Q101-001		
	Charged Device Model	Class C5 (+/- 2000V) <sup>†</sup>		
		AEC-Q101-005		
RoHS Compliant		Yes		

<sup>†</sup> Highest passing voltage.

### **Revision History**

Date	Comments		
10/27/2015	Updated datasheet with corporate template		
	Corrected ordering table on page 1.		
8/23/2017	Corrected part marking on pages 8,9		

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## **WARNINGS**

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Except as otherwise explicitly approved by Infineon Technologies in a written document signed by authorized representatives of Infineon Technologies, Infineon Technologies' products may <u>not</u> be used in any applications where a failure of the product or any consequences of the use thereof can reasonably be expected to result in personal injury.

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